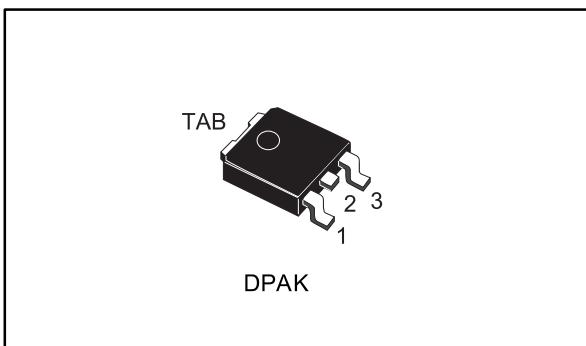
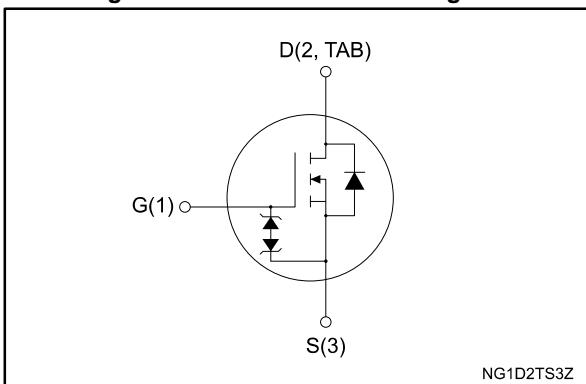


## N-channel 500 V, 0.299 Ω typ., 11 A MDmesh™ DM2 Power MOSFET in a DPAK package

Datasheet - production data



**Figure 1: Internal schematic diagram**



### Features

| Order code  | V <sub>DS</sub> | R <sub>DS(on)</sub> max. | I <sub>d</sub> |
|-------------|-----------------|--------------------------|----------------|
| STD12N50DM2 | 500 V           | 0.350 Ω                  | 11 A           |

- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

### Applications

- Switching applications

### Description

This high voltage N-channel Power MOSFET is part of the MDmesh DM2 fast recovery diode series. It offers very low recovery charge and time (Qrr, trr) combined with low R<sub>DS(on)</sub>, rendering it suitable for the most demanding high efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

**Table 1: Device summary**

| Order code  | Marking  | Package | Packing       |
|-------------|----------|---------|---------------|
| STD12N50DM2 | 12N50DM2 | DPAK    | Tape and reel |

## Contents

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# 1 Electrical ratings

Table 2: Absolute maximum ratings

| Symbol         | Parameter   | Value      | Unit             |
|----------------|---|------------|------------------|
| $V_{GS}$       | Gate-source voltage                                     | $\pm 25$   | V                |
| $I_D$          | Drain current (continuous) at $T_C = 25^\circ\text{C}$  | 11         | A                |
| $I_D$          | Drain current (continuous) at $T_C = 100^\circ\text{C}$ | 8          |                  |
| $I_{DM}^{(1)}$ | Drain current (pulsed)                                  | 44         | A                |
| $P_{TOT}$      | Total dissipation at $T_C = 25^\circ\text{C}$           | 110        | W                |
| $dv/dt^{(2)}$  | Peak diode recovery voltage slope                       | 40         | V/ns             |
| $dv/dt^{(3)}$  | MOSFET dv/dt ruggedness                                 | 50         | V/ns             |
| $T_{stg}$      | Storage temperature range                               | -55 to 150 | $^\circ\text{C}$ |
| $T_j$          | Operating junction temperature range                    |            |                  |

**Notes:**

(1) Pulse width limited by safe operating area.

(2)  $I_{SD} \leq 11$  A,  $dI/dt \leq 400$  A/ $\mu\text{s}$ ;  $V_{DS}$  peak <  $V_{(BR)DSS}$ ,  $V_{DD} = 80\%$   $V_{(BR)DSS}$ (3)  $V_{DS} \leq 400$  V

Table 3: Thermal data

| Symbol              | Parameter                            | Value | Unit               |
|---------------------|--------------------------------------|-------|--------------------|
| $R_{thj-case}$      | Thermal resistance junction-case max | 1.14  | $^\circ\text{C/W}$ |
| $R_{thj-pcb}^{(1)}$ | Thermal resistance junction-pcb max  | 50    |                    |

**Notes:**(1) When mounted on a 1-inch<sup>2</sup> FR-4, 2 oz Cu board

Table 4: Avalanche characteristics

| Symbol   | Parameter  | Value | Unit |
|----------|--|-------|------|
| $I_{AR}$ | Avalanche current, repetitive or not repetitive (pulse width limited by $T_{jmax}$ )                 | 2.5   | A    |
| $E_{AS}$ | Single pulse avalanche energy (starting $T_j = 25^\circ\text{C}$ , $I_D = I_{AR}$ , $V_{DD} = 50$ V) | 320   | mJ   |

## 2 Electrical characteristics

( $T_C = 25^\circ\text{C}$  unless otherwise specified).

**Table 5: Static**

| Symbol                      | Parameter                         | Test conditions  | Min. | Typ.  | Max.     | Unit          |
|-----------------------------|-----------------------------------|--|------|-------|----------|---------------|
| $V_{(\text{BR})\text{DSS}}$ | Drain-source breakdown voltage    | $V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$   | 500  |       |          | V             |
| $I_{\text{DSS}}$            | Zero gate voltage drain current   | $V_{GS} = 0 \text{ V}, V_{DS} = 500 \text{ V}$   |      |       | 1        | $\mu\text{A}$ |
|                             |                                   | $V_{GS} = 0 \text{ V}, V_{DS} = 500 \text{ V}, T_C = 125^\circ\text{C}$ <sup>(1)</sup> |      |       | 100      | $\mu\text{A}$ |
| $I_{GSS}$                   | Gate-body leakage current         | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$                                      |      |       | $\pm 10$ | $\mu\text{A}$ |
| $V_{GS(\text{th})}$         | Gate threshold voltage            | $V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$   | 3    | 4     | 5        | V             |
| $R_{DS(\text{on})}$         | Static drain-source on-resistance | $V_{GS} = 10 \text{ V}, I_D = 5.5 \text{ A}$   |      | 0.299 | 0.350    | $\Omega$      |

**Notes:**

<sup>(1)</sup>Defined by design, not subject to production test.

**Table 6: Dynamic**

| Symbol                               | Parameter                     | Test conditions   | Min. | Typ. | Max. | Unit     |
|--------------------------------------|-------------------------------|---|------|------|------|----------|
| $C_{iss}$                            | Input capacitance             | $V_{DS} = 100 \text{ V}, f = 1 \text{ MHz}, V_{GS} = 0 \text{ V}$   | -    | 628  | -    | pF       |
| $C_{oss}$                            | Output capacitance            |   | -    | 38   | -    | pF       |
| $C_{rss}$                            | Reverse transfer capacitance  |   | -    | 1.2  | -    | pF       |
| $C_{oss \text{ eq.}}$ <sup>(1)</sup> | Equivalent output capacitance | $V_{DS} = 0 \text{ V to } 400 \text{ V}, V_{GS} = 0 \text{ V}$  | -    | 69   | -    | pF       |
| $R_G$                                | Intrinsic gate resistance     | $f = 1 \text{ MHz}$ open drain  | -    | 7    | -    | $\Omega$ |
| $Q_g$                                | Total gate charge             | $V_{DD} = 400 \text{ V}, I_D = 11 \text{ A}, V_{GS} = 10 \text{ V}$ (see <a href="#">Figure 15: "Test circuit for gate charge behavior"</a> ) | -    | 16   | -    | nC       |
| $Q_{gs}$                             | Gate-source charge            |   | -    | 4.6  | -    | nC       |
| $Q_{gd}$                             | Gate-drain charge             |   | -    | 7    | -    | nC       |

**Notes:**

<sup>(1)</sup>  $C_{oss \text{ eq.}}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$

**Table 7: Switching times**

| Symbol       | Parameter           | Test conditions   | Min. | Typ. | Max. | Unit |
|--------------|---------------------|---|------|------|------|------|
| $t_{d(on)}$  | Turn-on delay time  | $V_{DD} = 250 \text{ V}, I_D = 5.5 \text{ A}$<br>$R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <a href="#">Figure 14: "Test circuit for resistive load switching times"</a> and <a href="#">Figure 19: "Switching time waveform"</a> ) | -    | 12.5 | -    | ns   |
| $t_r$        | Rise time           |   | -    | 9    | -    | ns   |
| $t_{d(off)}$ | Turn-off-delay time |   | -    | 28   | -    | ns   |
| $t_f$        | Fall time           |   | -    | 9.8  | -    | ns   |

Table 8: Source drain diode

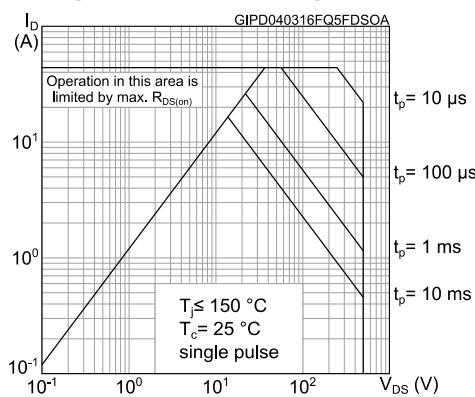
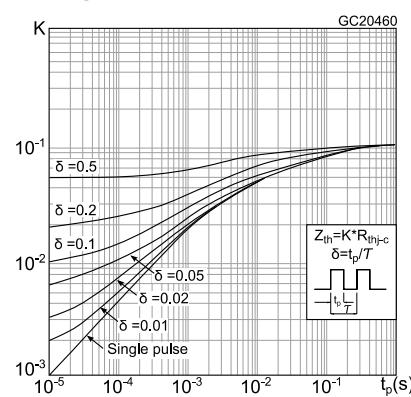
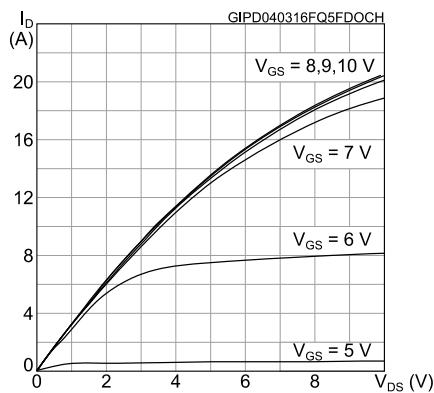
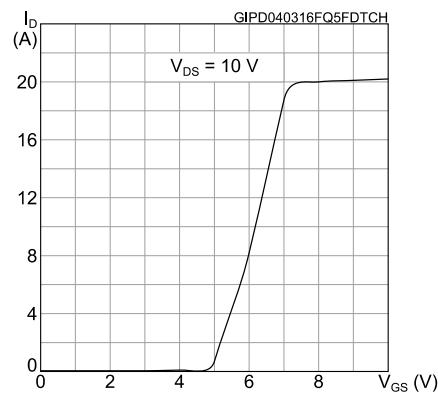
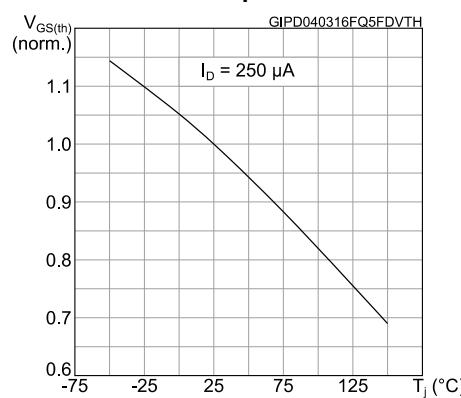
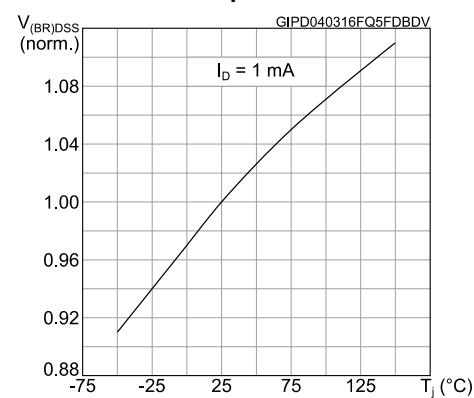
| Symbol          | Parameter                     | Test conditions  | Min. | Typ.  | Max. | Unit          |
|-----------------|-------------------------------|--|------|-------|------|---------------|
| $I_{SD}$        | Source-drain current          |  | -    |       | 11   | A             |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) |  | -    |       | 44   | A             |
| $V_{SD}^{(2)}$  | Forward on voltage            | $V_{GS} = 0 \text{ V}$ , $I_{SD} = 11 \text{ A}$   | -    |       | 1.6  | V             |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 11 \text{ A}$ , $di/dt = 100 \text{ A}/\mu\text{s}$ ,<br>$V_{DD} = 60 \text{ V}$ (see <a href="#">Figure 16: "Test circuit for inductive load switching and diode recovery times"</a> )                                | -    | 140   |      | ns            |
| $Q_{rr}$        | Reverse recovery charge       |  | -    | 0.707 |      | $\mu\text{C}$ |
| $I_{RRM}$       | Reverse recovery current      |  | -    | 10.1  |      | A             |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 11 \text{ A}$ , $di/dt = 100 \text{ A}/\mu\text{s}$ ,<br>$V_{DD} = 60 \text{ V}$ , $T_j = 150^\circ\text{C}$ (see<br><a href="#">Figure 16: "Test circuit for inductive load switching and diode recovery times"</a> ) | -    | 190   |      | ns            |
| $Q_{rr}$        | Reverse recovery charge       |  | -    | 1.111 |      | $\mu\text{C}$ |
| $I_{RRM}$       | Reverse recovery current      |  | -    | 11.7  |      | A             |

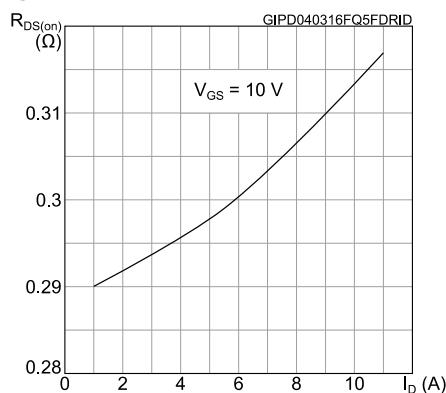
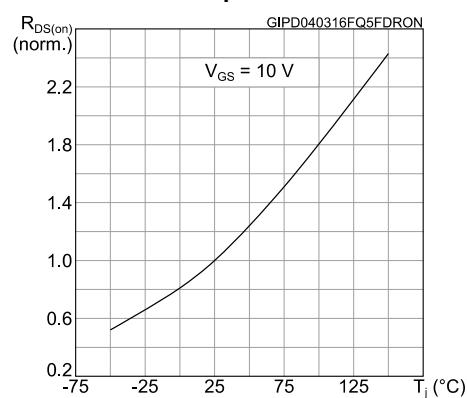
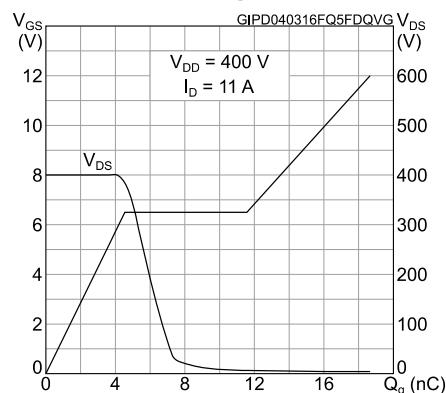
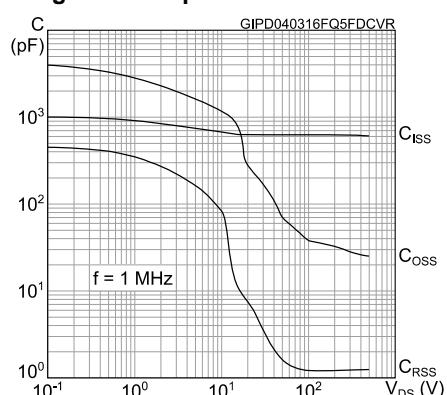
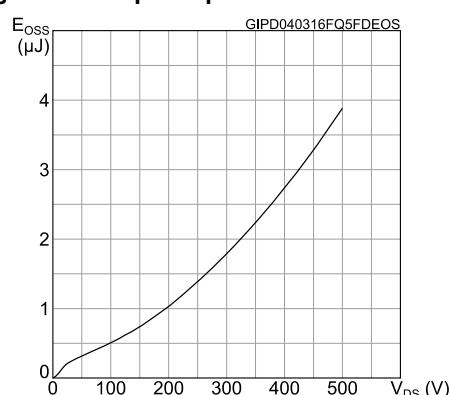
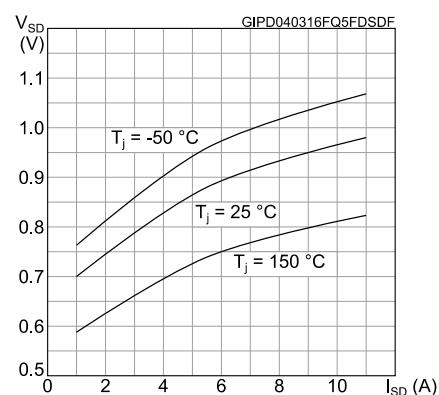
**Notes:**

(1)Pulse width is limited by safe operating area

(2)Pulse test: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

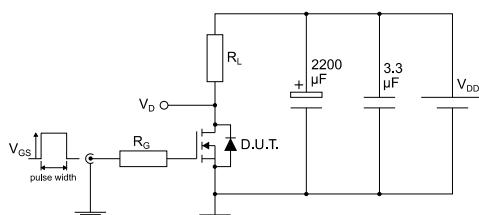
## 2.1 Electrical characteristics (curves)

**Figure 2: Safe operating area****Figure 3: Thermal impedance****Figure 4: Output characteristics****Figure 5: Transfer characteristics****Figure 6: Normalized gate threshold voltage vs. temperature****Figure 7: Normalized V(BR)DSS vs. temperature**

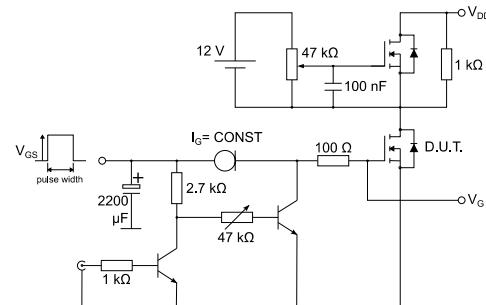
**Figure 8: Static drain-source on-resistance****Figure 9: Normalized on-resistance vs. temperature****Figure 10: Gate charge vs. gate-source voltage****Figure 11: Capacitance variations****Figure 12: Output capacitance stored energy****Figure 13: Source-drain diode forward characteristics**

### 3 Test circuits

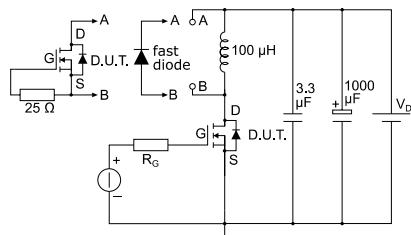
**Figure 14: Test circuit for resistive load switching times**



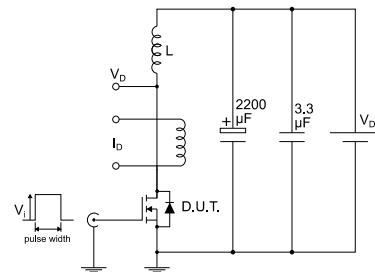
**Figure 15: Test circuit for gate charge behavior**



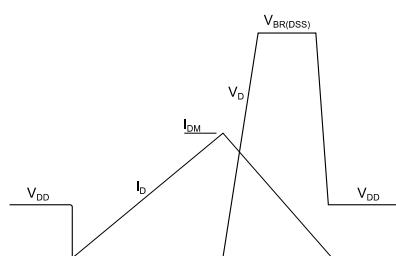
**Figure 16: Test circuit for inductive load switching and diode recovery times**



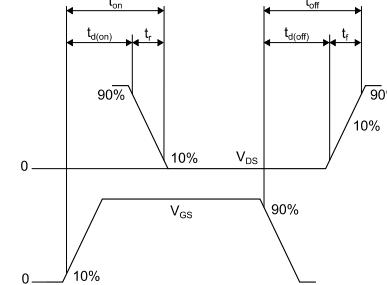
**Figure 17: Unclamped inductive load test circuit**



**Figure 18: Unclamped inductive waveform**



**Figure 19: Switching time waveform**

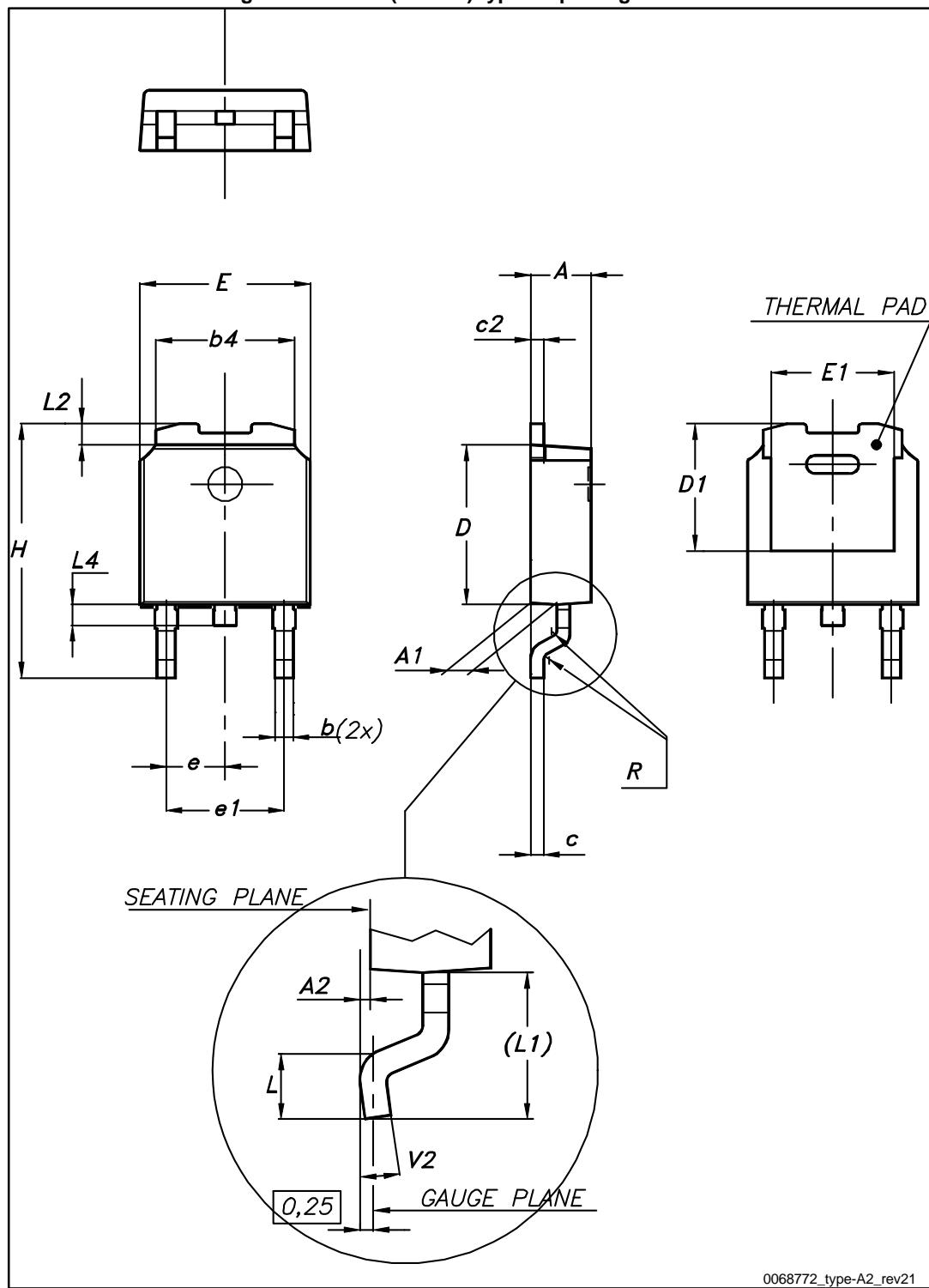


## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).  
ECOPACK® is an ST trademark.

## 4.1 DPAK package information

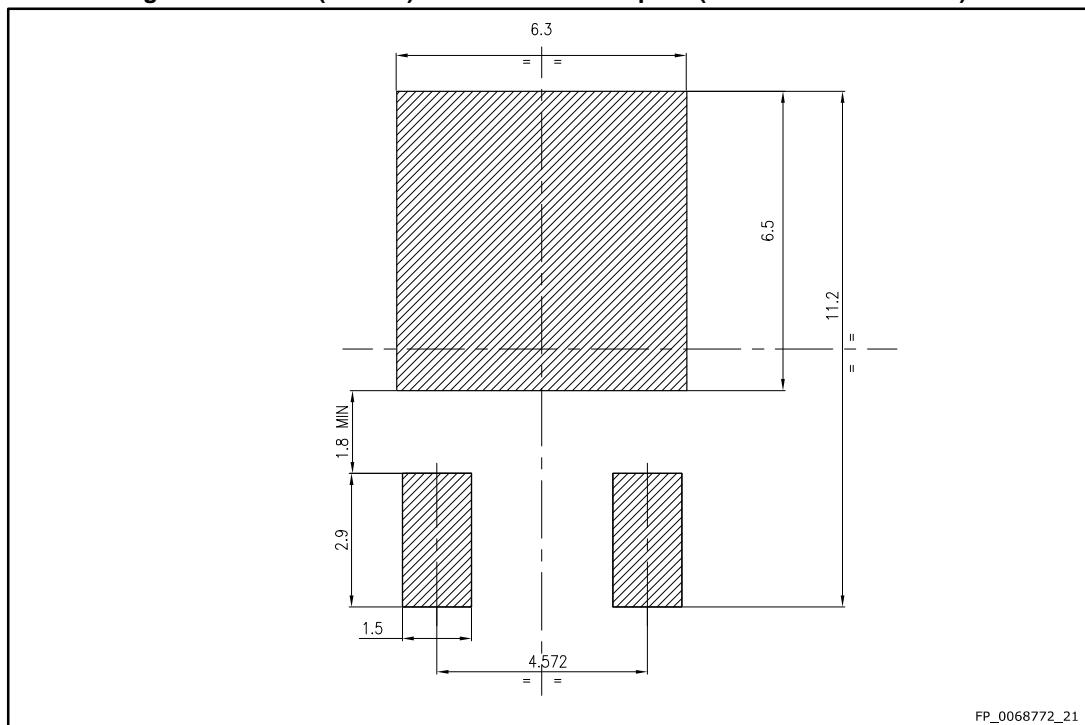
Figure 20: DPAK (TO-252) type A2 package outline



**Table 9: DPAK (TO-252) type A2 mechanical data**

| Dim. | mm   |      |       |
|------|------|------|-------|
|      | Min. | Typ. | Max.  |
| A    | 2.20 |      | 2.40  |
| A1   | 0.90 |      | 1.10  |
| A2   | 0.03 |      | 0.23  |
| b    | 0.64 |      | 0.90  |
| b4   | 5.20 |      | 5.40  |
| c    | 0.45 |      | 0.60  |
| c2   | 0.48 |      | 0.60  |
| D    | 6.00 |      | 6.20  |
| D1   | 4.95 | 5.10 | 5.25  |
| E    | 6.40 |      | 6.60  |
| E1   | 5.10 | 5.20 | 5.30  |
| e    | 2.16 | 2.28 | 2.40  |
| e1   | 4.40 |      | 4.60  |
| H    | 9.35 |      | 10.10 |
| L    | 1.00 |      | 1.50  |
| L1   | 2.60 | 2.80 | 3.00  |
| L2   | 0.65 | 0.80 | 0.95  |
| L4   | 0.60 |      | 1.00  |
| R    |      | 0.20 |       |
| V2   | 0°   |      | 8°    |

Figure 21: DPAK (TO-252) recommended footprint (dimensions are in mm)



FP\_0068772\_21

## 4.2 Packing information

Figure 22: DPAK (TO-252) tape outline

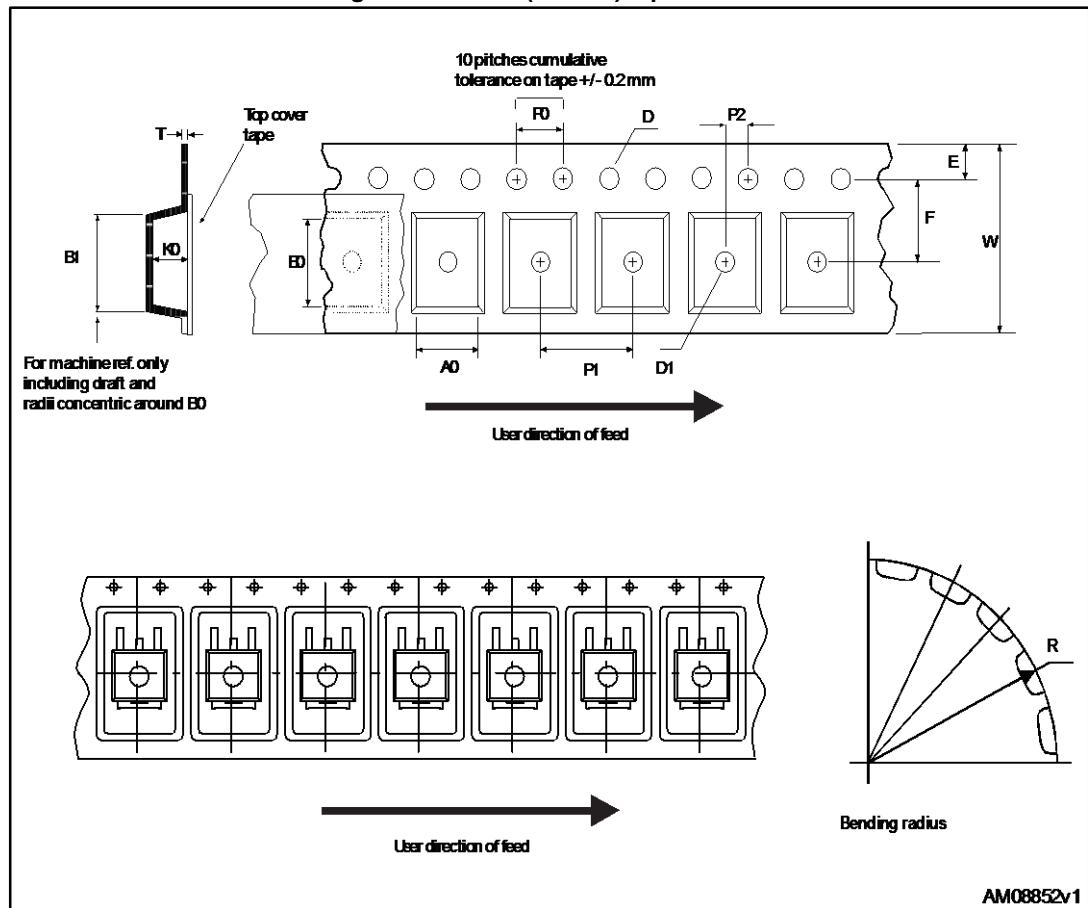


Figure 23: DPAK (TO-252) reel outline

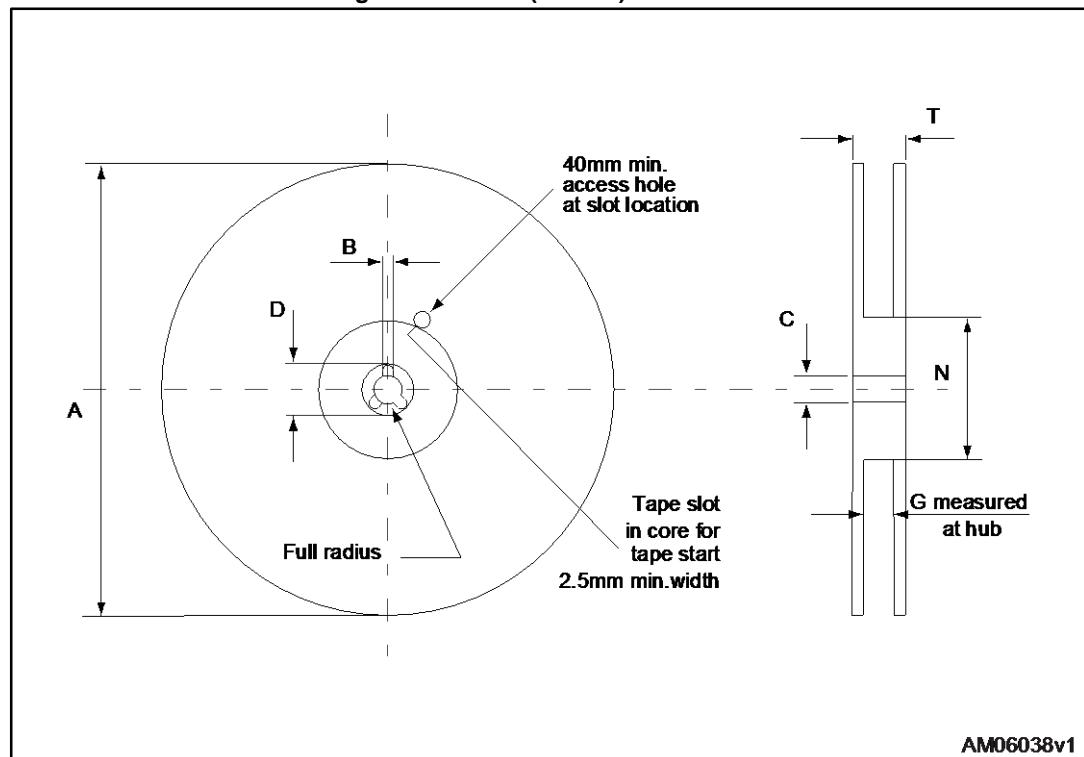


Table 10: DPAK (TO-252) tape and reel mechanical data

| Tape |      |      | Reel      |      |      |
|------|------|------|-----------|------|------|
| Dim. | mm   |      | Dim.      | mm   |      |
|      | Min. | Max. |           | Min. | Max. |
| A0   | 6.8  | 7    | A         |      | 330  |
| B0   | 10.4 | 10.6 | B         | 1.5  |      |
| B1   |      | 12.1 | C         | 12.8 | 13.2 |
| D    | 1.5  | 1.6  | D         | 20.2 |      |
| D1   | 1.5  |      | G         | 16.4 | 18.4 |
| E    | 1.65 | 1.85 | N         | 50   |      |
| F    | 7.4  | 7.6  | T         |      | 22.4 |
| K0   | 2.55 | 2.75 |           |      |      |
| P0   | 3.9  | 4.1  | Base qty. |      | 2500 |
| P1   | 7.9  | 8.1  | Bulk qty. |      | 2500 |
| P2   | 1.9  | 2.1  |           |      |      |
| R    | 40   |      |           |      |      |
| T    | 0.25 | 0.35 |           |      |      |
| W    | 15.7 | 16.3 |           |      |      |

## 5 Revision history

Table 11: Document revision history

| Date        | Revision | Changes   |
|-------------|----------|---|
| 26-Aug-2014 | 1        | First release.  |
| 07-Mar-2016 | 2        | <p>Text and formatting changes throughout document</p> <p>In <i>Section 1: "Electrical ratings"</i>:</p> <ul style="list-style-type: none"><li>- updated <i>Table 4: "Avalanche characteristics"</i></li></ul> <p>In <i>Section 2: "Electrical characteristics"</i></p> <ul style="list-style-type: none"><li>- updated <i>Table 6: "Dynamic"</i>, <i>Table 7: "Switching times"</i> and <i>Table 8: "Source drain diode"</i></li></ul> <p>Added <i>Section 2.1: "Electrical characteristics (curves)"</i></p> <p>Updated <i>Section 4: "Package information"</i></p> |

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